Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
10/723,664	BURKE ET AL.	
Examiner	Art Unit	
Edan Orgad	2618	,

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SEARCH NOT (INCLUDING SEARCH)
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EAST class/subclass search NPL: IEEE Xplore Inventor name search	3/26/2007	. EO
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